

Description

TheVSM80N08uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications.

General Features

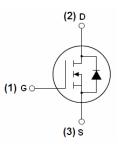
• $V_{DS} = 85V, I_D = 80A$ $R_{DS(ON)} < 8.5mΩ @ V_{GS} = 10V$ (Typ:6.8mΩ)

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Special designed for convertors and power controls
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

Application

- Power switching application
- Hard switched and High frequency circuits
- Uninterruptible power supply





Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM80N08-TC	VSM80N08	TO-220C	-	-	-

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	85	V
Gate-Source Voltage	V _G s	±20	V
Drain Current-Continuous	I _D	80	А
Drain Current-Continuous(T _C =100°ℂ)	I _D (100°C)	60	А
Pulsed Drain Current	I _{DM}	320	А
Maximum Power Dissipation	P _D	170	W
Peak diode recovery voltage	dv/dt	15	V/ns
Derating factor		1.13	W/℃
Single pulse avalanche energy (Note 5)	E _{AS}	620	mJ
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 175	$^{\circ}$ C



Thermal Characteristic

Thermal Resistance,Junction-to-Case ^(Note 2)	$R_{ heta JC}$	0.88	°C/W	
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Electrical Characteristics (T_A=25 ℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	•					
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	85	89	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =85V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)	<u> </u>		•			
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2	2.85	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =40A	-	6.8	8.5	mΩ
Forward Transconductance	g FS	V _{DS} =25V,I _D =40A	110	-	-	S
Dynamic Characteristics (Note4)	-		•			•
Input Capacitance	C_{lss}	\\ 05\\\\ 0\\	-	4100	-	PF
Output Capacitance	Coss	$V_{DS}=25V,V_{GS}=0V,$	-	343	-	PF
Reverse Transfer Capacitance	C _{rss}	F=1.0MHz	-	258	-	PF
Switching Characteristics (Note 4)	•		•			•
Turn-on Delay Time	t _{d(on)}		-	18	-	nS
Turn-on Rise Time	t _r	VDD=30V,ID=2A,RL=15Ω ,RG=2.5Ω,VGS=10V	-	12	-	nS
Turn-Off Delay Time	t _{d(off)}		-	56	-	nS
Turn-Off Fall Time	t _f		-	15	-	nS
Total Gate Charge	Qg	V _{DS} =42.5V,I _D =50A,	-	90	-	nC
Gate-Source Charge	Q_{gs}		-	23	-	nC
Gate-Drain Charge	Q_{gd}	V _{GS} =10V	-	30	-	nC
Drain-Source Diode Characteristics	-		•			•
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =40A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	80	Α
Reverse Recovery Time	t _{rr}	Tj=25℃,I _F =75A	-		36	nS
Reverse Recovery Charge	Qrr	di/dt=100A/μs ^(Note3)	-		56	nC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

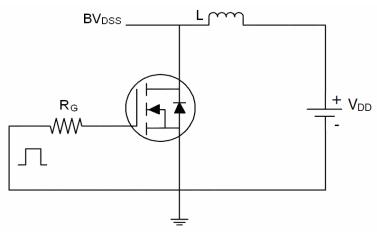
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- **3.** Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- **5.** EAS condition: Tj=25 $^{\circ}\text{C}$,VDD=40V,VG=10V,L=0.5mH,Rg=25 Ω

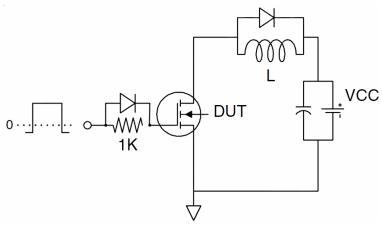


Test Circuit

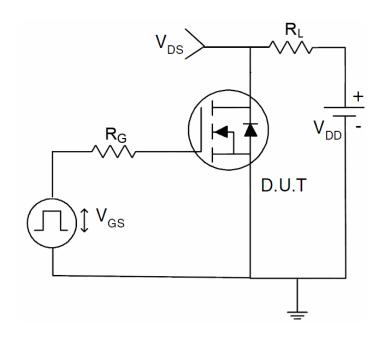
1) E_{AS} Test Circuits



2) Gate Charge Test Circuit



3) Switch Time Test Circuit





Typical Electrical and Thermal Characteristics (Curves)

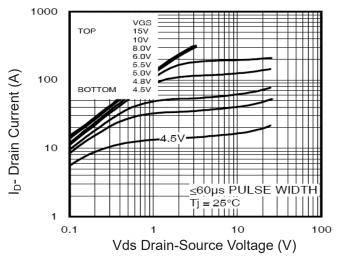


Figure 1 Output Characteristics

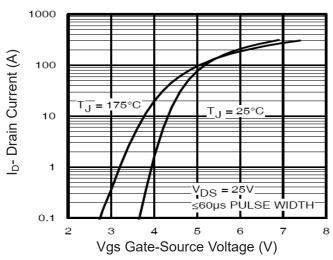


Figure 2 Transfer Characteristics

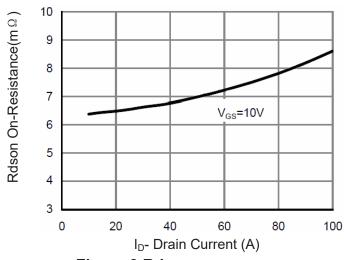


Figure 3 Rdson- Drain Current

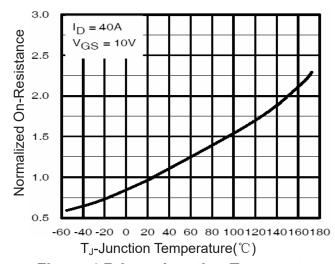


Figure 4 Rdson-Junction Temperature

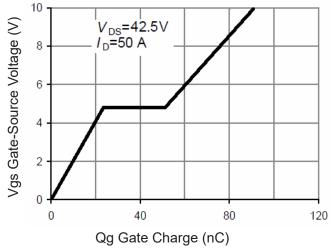


Figure 5 Gate Charge

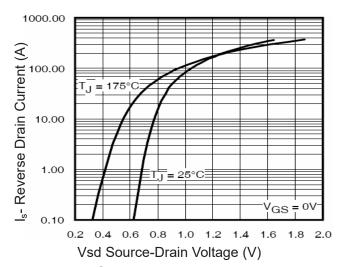
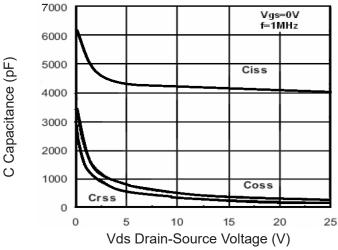


Figure 6 Source- Drain Diode Forward

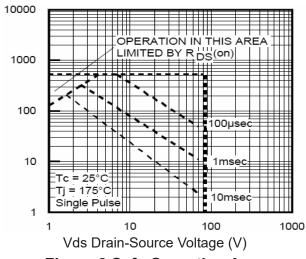




1.15 $I_D = 250 \mu A$ 1.05
1.05
1.09
0.95
0.85
-75 -50 -25 0 25 50 75 100 125 150 175
T_J-Junction Temperature(°C)

Figure 7 Capacitance vs Vds

Figure 9 BV_{DSS} vs Junction Temperature



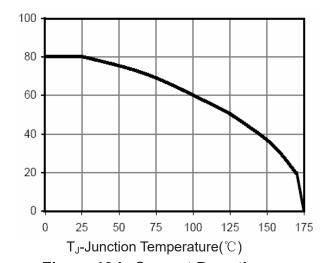
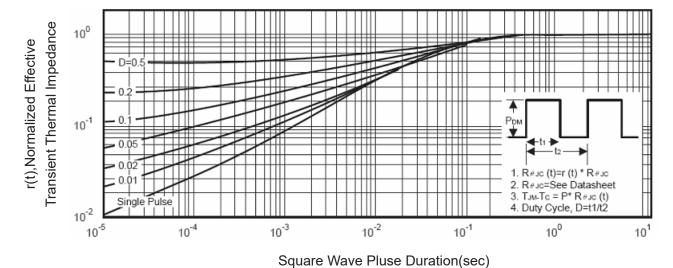


Figure 8 Safe Operation Area

Figure 10 I_D Current De-rating



D- Drain Current (A)

Figure 11 Normalized Maximum Transient Thermal Impedance